


<b>Search Notes</b>  	<b>Application/Control No.</b>  10553416	<b>Applicant(s)/Patent Under Reexamination</b>  OHMI ET AL.
	<b>Examiner</b>  Thien F Tran	<b>Art Unit</b>  2811

SEARCHED			
Class	Subclass	Date	Examiner
257	77, 410, 411	04/11/2008	TT

SEARCH NOTES		
Search Notes	Date	Examiner
Search history printout	04/04/2008	TT
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Search history printout	04/06/2008	TT
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